

**PATENT** 

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Serial No.: 10/565,006

Confirmation No.:

In re Application of:

Y. SOGAWA et al.

Group Art Unit:

Filed: January 18, 2006

For: SEMICONDUCTOR INTEGRATED CIRCUIT

## INFORMATION DISCLOSURE STATEMENT

Customer Window
U.S. Patent & Trademark Office
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir:

Pursuant to 37 CFR 1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached Form PTO-1449. A copy of each of the listed foreign documents is enclosed.

Partial translations with respect to each of Japanese Published Patent Applications 7-37943 and 2002-22809 are provided herewith. U.S. 2003/0032263 is the English-language equivalent of JP 2003-124274, the relevancy of which is discussed in the Written Opinion. Additionally, JP 7-37943, 2002-22809 and 2003-124274 are cited in the International Search

App. No. 10/565,006 Atty. Dkt. No. 28951.1169

Report. Japanese Published Patent Application 2001-93947 is discussed at page 1 of the specification. .

The above information is presented so that the Patent and Trademark Office may, in the first instance, determine any materiality thereof to the claimed invention. See 37 CFR 1.104(a) and 1.106(b) concerning the PTO duty to consider and use any such information. It is respectfully requested that this information be expressly considered during the prosecution of this application, and that this reference be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

Respectfully Submitted,

STEPTOE & JOHNSON LLP

Roger W. Parkhurst

Registration No. 25,177

RWP/tlpdg

Atty. Dkt: 28951.1169

STEPTOE & JOHNSON LLP 1330 Connecticut Ave., N.W.

Washington, D.C. 20036

(202) 429-6420

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FORM 1449	(S&J Version)	Docket No.: 28951.1169							
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U.S. PATENT				DOCUMENTS					
Initials*	Document No.	Date MM/YYYY		Inventor	Class	Subclass	Filing If Appr		
	5,719,449	02/1998	Strauss		257	786			
	2003/0032263	02/2003	Nagao et al.		438	462			
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Examiner's Initials*	Document No.	Date	]	Country	Class	Subclass		Translation	
		MM/YYYY					Yes	No	
	2001-93947	04/2002	Japan				Abstract		
	52-67741	06/1977	Japan					No	
	7-37943	02/1995	Japan					No	
	2002-22809	01/2002	Japan		ļ			No	
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Signature

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Examiner's

Date Considered